

HIGH DENSITY SEMICONDUCTOR MEMORY CELL AND MEMORY
ARRAY USING A SINGLE TRANSISTOR AND HAVING COUNTER-DOPED POLY
AND BURIED DIFFUSION WORDLINE

ABSTRACT OF THE DISCLOSURE

A programmable memory cell comprised of a transistor located at the crosspoint of a column bitline and a row wordline is disclosed. The transistor has its gate formed from the column bitline and its source connected to the row wordline. The memory cell is programmed by applying a voltage potential between the column bitline and the row wordline to produce a programmed p+ region to form a p-n diode in the substrate underlying the gate of the transistor. Further, the wordline is formed from a buried diffusion N+ layer while the column bitline is formed from a counterdoped polysilicon layer.